

Notice of References Cited	Application/Control No. 10/518,178	Applicant(s)/Patent Under Reexamination VERHEES ET AL.	
	Examiner Minh D. A	Art Unit 2821	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,348,819	02-2002	Ten Pierick et al.	327/110
	B	US-6,046,623	04-2000	Hasegawa, Kazuo	327/509
	C	US-5,397,914	03-1995	Suda et al.	257/570
	D	US-6,285,142	09-2001	Kim, Eun-Sup	315/371
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.